

**Notice of References Cited**

Application/Control No.

10/656,990

Applicant(s)/Patent Under  
Reexamination  
VAN DE LIGT ET AL.

Examiner

M.N. Von Buhr

Art Unit

2125

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,673,647 A	10-1997	Pratt, William C.	119/51.02
*	B	US-6,000,361 A	12-1999	Pratt, William C.	119/51.02
*	C	US-6,200,210 B1	03-2001	Pratt, William C.	452/52
*	D	US-6,318,289 B1	11-2001	Pratt, William C.	119/51.02
*	E	US-2001/0044579 A1	11-2001	Pratt, William C.	600/437
*	F	US-6,358,546 B1	03-2002	Bebiak et al.	426/232
*	G	US-2002/0050248 A1	05-2002	Pratt, William C.	119/51.02
*	H	US-2002/0081356 A1	06-2002	Bebiak et al.	426/232
*	I	US-2002/0120402 A1	08-2002	Burghardi et al.	702/19
*	J	US-2003/0188689 A1	10-2003	Pratt, William C.	119/51.02
*	K	US-2004/0098209 A1	05-2004	Burghardi et al.	702/032
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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